

**Notice of References Cited**Application/Control No.  
**09/545,367**Applicant(s)/Patent Under Reexam  
**Piechnick**Examiner  
**Tuyen T. Nguyen**Art Unit  
**2832**

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**U.S. PATENT DOCUMENTS**

	<b>Document Number</b> Country Code-Number-Kind Code	<b>Date</b> MM-YYYY <sup>1</sup>	<b>Name</b>	<b>Classification</b> <sup>2</sup>	
A	4,596,974	6/1986	Tobben et al.	336	198
B					
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**FOREIGN PATENT DOCUMENTS**

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